Unit: mm

TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (L^2 - π -MOSV)

2SJ508

Chopper Regulator, DC-DC Converter and Motor Drive Applications

• 4-V gate drive

• Low drain-source ON resistance : RDS (ON) = 1.34Ω (typ.)

• High forward transfer admittance : $|Y_{fs}| = 0.7 \text{ S (typ.)}$

• Low leakage current $: I_{DSS} = -100 \mu A(max) (V_{DS} = -100 V)$

• Enhancement mode : $V_{th} = -0.8 \sim -2.0 \text{ V (V}_{DS} = -10 \text{ V, I}_{D} = -1 \text{ mA)}$

Absolute Maximum Ratings (Ta = 25°C)

Characteris	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	-100	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	-100	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	-1	Α	
Dialii Cuitelli	Pulse (Note 1)	I _{DP}	-3	Α	
Drain power dissipation	1	P_{D}	0.5	W	
Drain power dissipation	(Note 2)	PD	1.5	W	
Single pulse avalanche	energy (Note 3)	E _{AS}	136.5	mJ	
Avalanche current		I _{AR}	-1	Α	
Repetitive avalanche energy (Note 4)		E _{AR}	0.05	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

1. GATE
2. DRAIN (HEAT SINK)
3. SOURCE

4.6MAX.

1.6MAX.

0.4±0.05

1.5±0.1

1.5±0.1

1.5±0.1

1.5±0.1

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1.5±0.1

1.5±0.1

Weight: 0.05 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit	
Thermal resistance, channel to ambient	R _{th (ch-a)}	250	°C / W	

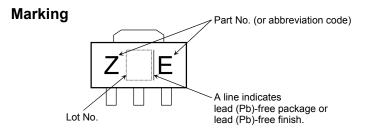
Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: Mounted on a ceramic substrate (25.4 mm × 25.4 mm × 0.8 mm)

Note 3: V_{DD} = -50 V, T_{ch} = 25°C (initial), L = 168 mH, R_G = 25 Ω , I_{AR} = -1 A

Note 4: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.



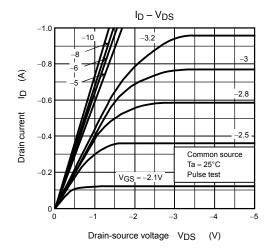


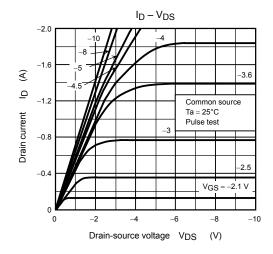
Electrical Characteristics (Ta = 25°C)

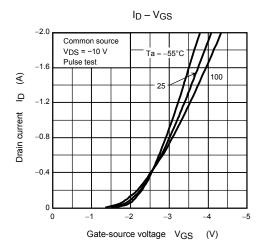
Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μΑ
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = -100 V, V _{GS} = 0 V	_	_	-100	μΑ
Drain-source br voltage	eakdown	V (BR) DSS	I _D = -10 mA, V _{GS} = 0 V	-100	_	_	٧
Gate threshold v	voltage	V_{th}	$V_{DS} = -10 \text{ V}, I_D = -1 \text{ mA}$	-0.8	_	-2.0	V
Drain-source ON resistance		Pro (OLI)	$V_{GS} = -4 \text{ V}, I_D = -0.5 \text{ A}$	_	1.68	2.5	Ω
		R _{DS} (ON)	$V_{GS} = -10 \text{ V}, I_D = -0.5 \text{ A}$	_	1.34	1.9	1 12
Forward transfer	r admittance	Y _{fs}	$V_{DS} = -10 \text{ V}, I_D = -0.5 \text{ A}$	0.3	0.7	_	S
Input capacitano	e	C _{iss}		_	135	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	_	22	_	pF
Output capacitance		Coss		_	48	_	
Switching time	Rise time	t _r	$V_{GS} = 10V$ $V_{DD} = -50V$ $V_{DD} = -50V$	_	20	_	
	Turn-on time	t _{on}		l	32		ns
	Fall time	t _f			25		118
	Turn-off time	t _{off}	Duty \leq 1%, t _w =10 μ s	-	130	_	
Total gate charge (Gate-source plus gate-drain)		Q_{g}	V _{DD} ≈ -80 V, V _{GS} = -10 V,	_	6.3	_	
Gate-source charge		Qgs	I _D = -1 A		4.1	_	nC
Gate-drain ("miller") charge		Q_{gd}		_	2.2	_	

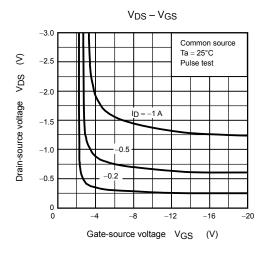
Source-Drain Ratings and Characteristics (Ta = 25°C)

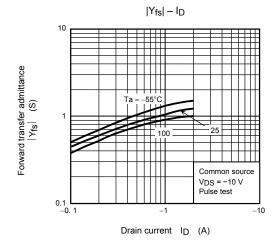
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	-1	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	-3	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = -1 A, V _{GS} = 0 V		_	1.5	V
Reverse recovery time	t _{rr}	I _{DR} = -1 A, V _{GS} = 0 V		90		ns
Reverse recovery charge	Q _{rr}	dl _{DR} / dt = 50 A / μs	_	180	_	nC

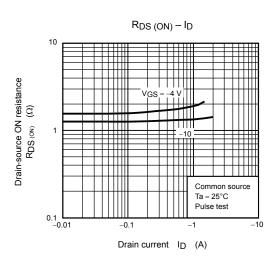


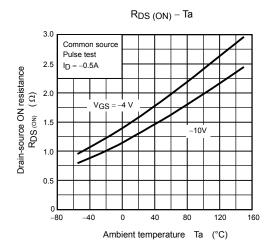


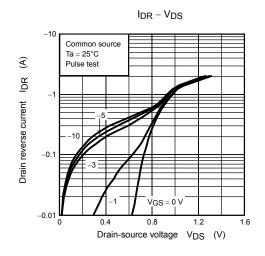


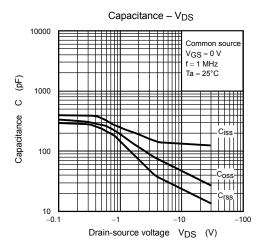


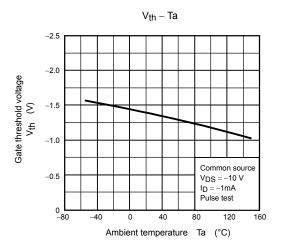


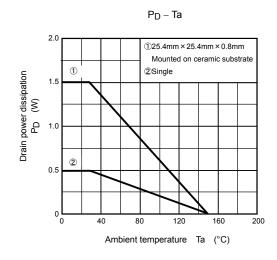


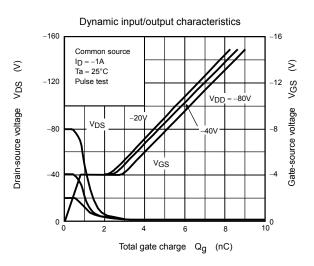


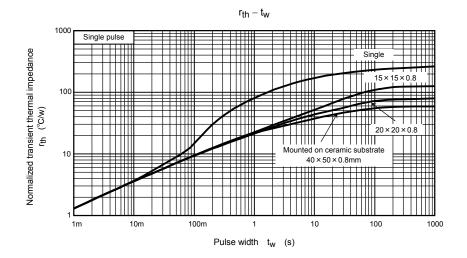




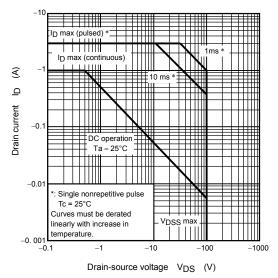


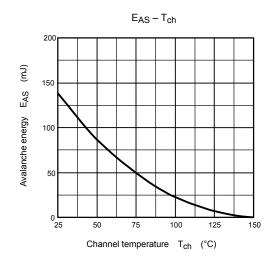


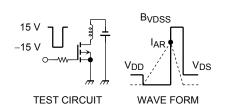












$$\begin{aligned} &R_{\text{G}}\text{=25}~\Omega\\ &V_{DD}=\text{-50}~V,~L=\text{168mH} \end{aligned} \qquad \text{EAS} = \frac{1}{2} \cdot L \cdot l^2 \cdot \left(\frac{\text{BVDSS}}{\text{BVDSS} - \text{VDD}} \right)$$

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20070701-EN

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